

<b>Notice of References Cited</b>	Application/Control No. 10/562,012	Applicant(s)/Patent Under Reexamination FURUSHIMA ET AL.	
	Examiner JOHN D. PHAM	Art Unit 2184	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,349,518	09-1994	Zifferer et al.	700/87
*	B	US-2002/0147505	10-2002	Beck et al.	700/18
*	C	US-5,886,274	03-1999	Jungleib, Stanley	84/601
*	D	US-4,455,619	06-1984	Masui et al.	345/530
*	E	US-5,717,588	02-1998	Yamane et al.	700/86
	E	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.